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"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "[Embedded - Microcontrollers](#)"

Details

| | |
|----------------------------|---|
| Product Status | Not For New Designs |
| Core Processor | S08 |
| Core Size | 8-Bit |
| Speed | 20MHz |
| Connectivity | I ² C, LINbus, SPI, UART/USART |
| Peripherals | LVD, POR, PWM, WDT |
| Number of I/O | 37 |
| Program Memory Size | 16KB (16K x 8) |
| Program Memory Type | FLASH |
| EEPROM Size | 256 x 8 |
| RAM Size | 2K x 8 |
| Voltage - Supply (Vcc/Vdd) | 2.7V ~ 5.5V |
| Data Converters | A/D 12x12b |
| Oscillator Type | Internal |
| Operating Temperature | -40°C ~ 105°C (TA) |
| Mounting Type | Surface Mount |
| Package / Case | 44-LQFP |
| Supplier Device Package | 44-LQFP (10x10) |
| Purchase URL | https://www.e-xfl.com/product-detail/nxp-semiconductors/mc9s08pa16vld |

- Input/Output
 - Up to 37 GPIOs including one output-only pin
 - One 8-bit keyboard interrupt module (KBI)
 - Two true open-drain output pins
 - Four, ultra-high current sink pins supporting 20 mA source/sink current
- Package options
 - 44-pin LQFP
 - 32-pin LQFP
 - 20-pin SOIC; 20-pin TSSOP
 - 16-pin TSSOP

1 Ordering parts

1.1 Determining valid orderable parts

Valid orderable part numbers are provided on the web. To determine the orderable part numbers for this device, go to freescale.com and perform a part number search for the following device numbers: PA16 and PA8.

2 Part identification

2.1 Description

Part numbers for the chip have fields that identify the specific part. You can use the values of these fields to determine the specific part you have received.

2.2 Format

Part numbers for this device have the following format:

MC 9 S08 PA AA (V) B CC

2.3 Fields

This table lists the possible values for each field in the part number (not all combinations are valid):

| Field | Description | Values |
|-------|------------------------------|--|
| MC | Qualification status | <ul style="list-style-type: none"> MC = fully qualified, general market flow |
| 9 | Memory | <ul style="list-style-type: none"> 9 = flash based |
| S08 | Core | <ul style="list-style-type: none"> S08 = 8-bit CPU |
| PA | Device family | <ul style="list-style-type: none"> PA |
| AA | Approximate flash size in KB | <ul style="list-style-type: none"> 16 = 16 KB 8 = 8 KB |
| (V) | Mask set version | <ul style="list-style-type: none"> (blank) = Any version A = Rev. 2 or later version, this is recommended for new design |

Table continues on the next page...

| Field | Description | Values |
|-------|----------------------------------|--|
| B | Operating temperature range (°C) | <ul style="list-style-type: none"> • V = -40 to 105 |
| CC | Package designator | <ul style="list-style-type: none"> • LD = 44-LQFP • LC = 32-LQFP • TJ = 20-TSSOP • WJ = 20-SOIC • TG = 16-TSSOP |

2.4 Example

This is an example part number:

MC9S08PA16VLD

3 Parameter Classification

The electrical parameters shown in this supplement are guaranteed by various methods. To give the customer a better understanding, the following classification is used and the parameters are tagged accordingly in the tables where appropriate:

Table 1. Parameter Classifications

| | |
|---|--|
| P | Those parameters are guaranteed during production testing on each individual device. |
| C | Those parameters are achieved by the design characterization by measuring a statistically relevant sample size across process variations. |
| T | Those parameters are achieved by design characterization on a small sample size from typical devices under typical conditions unless otherwise noted. All values shown in the typical column are within this category. |
| D | Those parameters are derived mainly from simulations. |

NOTE

The classification is shown in the column labeled “C” in the parameter tables where appropriate.

This device contains circuitry protecting against damage due to high static voltage or electrical fields; however, it is advised that normal precautions be taken to avoid application of any voltages higher than maximum-rated voltages to this high-impedance circuit. Reliability of operation is enhanced if unused inputs are tied to an appropriate logic voltage level (for instance, either V_{SS} or V_{DD}) or the programmable pullup resistor associated with the pin is enabled.

| Symbol | Description | Min. | Max. | Unit |
|-----------|---|----------------|----------------|------|
| V_{DD} | Supply voltage | -0.3 | 6.0 | V |
| I_{DD} | Maximum current into V_{DD} | — | 120 | mA |
| V_{DIO} | Digital input voltage (except RESET, EXTAL, XTAL, or true open drain pin PTA2 and PTA3) | -0.3 | $V_{DD} + 0.3$ | V |
| | Digital input voltage (true open drain pin PTA2 and PTA3) | -0.3 | 6 | V |
| V_{AIO} | Analog ¹ , RESET, EXTAL, and XTAL input voltage | -0.3 | $V_{DD} + 0.3$ | V |
| I_D | Instantaneous maximum current single pin limit (applies to all port pins) | -25 | 25 | mA |
| V_{DDA} | Analog supply voltage | $V_{DD} - 0.3$ | $V_{DD} + 0.3$ | V |

1. All digital I/O pins, except open-drain pin PTA2 and PTA3, are internally clamped to V_{SS} and V_{DD} . PTA2 and PTA3 is only clamped to V_{SS} .

5 General

5.1 Nonswitching electrical specifications

5.1.1 DC characteristics

This section includes information about power supply requirements and I/O pin characteristics.

Table 2. DC characteristics

| Symbol | C | Descriptions | | | Min | Typical ¹ | Max | Unit |
|----------|---|---------------------|---|---------------------------|----------------|----------------------|-----|------|
| — | — | Operating voltage | | — | 2.7 | — | 5.5 | V |
| V_{OH} | C | Output high voltage | All I/O pins, standard-drive strength | 5 V, $I_{load} = -5$ mA | $V_{DD} - 0.8$ | — | — | V |
| | C | | | 3 V, $I_{load} = -2.5$ mA | $V_{DD} - 0.8$ | — | — | V |
| | C | | High current drive pins, high-drive strength ² | 5 V, $I_{load} = -20$ mA | $V_{DD} - 0.8$ | — | — | V |
| | C | | | 3 V, $I_{load} = -10$ mA | $V_{DD} - 0.8$ | — | — | V |

Table continues on the next page...

Table 2. DC characteristics (continued)

| Symbol | C | Descriptions | | | Min | Typical ¹ | Max | Unit |
|------------------------------|---|---|--|--|------------------------|----------------------|------------------------|------|
| I _{OHT} | D | Output high current | Max total I _{OH} for all ports | 5 V | — | — | -100 | mA |
| | | | | 3 V | — | — | -50 | |
| V _{OL} | C | Output low voltage | All I/O pins, standard-drive strength | 5 V, I _{load} = 5 mA | — | — | 0.8 | V |
| | C | | | 3 V, I _{load} = 2.5 mA | — | — | 0.8 | V |
| | C | High current drive pins, high-drive strength ² | | 5 V, I _{load} = 20 mA | — | — | 0.8 | V |
| | C | | | 3 V, I _{load} = 10 mA | — | — | 0.8 | V |
| I _{OLT} | D | Output low current | Max total I _{OL} for all ports | 5 V | — | — | 100 | mA |
| | | | | 3 V | — | — | 50 | |
| V _{IH} | P | Input high voltage | All digital inputs | V _{DD} > 4.5V | 0.70 × V _{DD} | — | — | V |
| | C | | | V _{DD} > 2.7V | 0.75 × V _{DD} | — | — | |
| V _{IL} | P | Input low voltage | All digital inputs | V _{DD} > 4.5V | — | — | 0.30 × V _{DD} | V |
| | C | | | V _{DD} > 2.7V | — | — | 0.35 × V _{DD} | |
| V _{hys} | C | Input hysteresis | All digital inputs | — | 0.06 × V _{DD} | — | — | mV |
| I _{IN} | P | Input leakage current | All input only pins (per pin) | V _{IN} = V _{DD} or V _{SS} | — | 0.1 | 1 | μA |
| I _{OZ} | P | Hi-Z (off-state) leakage current | All input/output (per pin) | V _{IN} = V _{DD} or V _{SS} | — | 0.1 | 1 | μA |
| I _{OZTOT} | C | Total leakage combined for all inputs and Hi-Z pins | All input only and I/O | V _{IN} = V _{DD} or V _{SS} | — | — | 2 | μA |
| R _{PU} | P | Pullup resistors | All digital inputs, when enabled (all I/O pins other than PTA2 and PTA3) | — | 30.0 | — | 50.0 | kΩ |
| R _{PU} ³ | P | Pullup resistors | PTA2 and PTA3 pin | — | 30.0 | — | 60.0 | kΩ |
| I _{IC} | D | DC injection current ^{4, 5, 6} | Single pin limit | V _{IN} < V _{SS} , V _{IN} > V _{DD} | -0.2 | — | 2 | mA |
| | | | Total MCU limit, includes sum of all stressed pins | | -5 | — | 25 | |
| C _{in} | C | Input capacitance, all pins | | — | — | — | 7 | pF |
| V _{RAM} | C | RAM retention voltage | | — | 2.0 | — | — | V |

- Typical values are measured at 25 °C. Characterized, not tested.
- Only PTB4, PTB5, PTD0, PTD1 support ultra high current output.
- The specified resistor value is the actual value internal to the device. The pullup value may appear higher when measured externally on the pin.
- All functional non-supply pins, except for , are internally clamped to V_{SS} and V_{DD}.
- Input must be current-limited to the value specified. To determine the value of the required current-limiting resistor, calculate resistance values for positive and negative clamp voltages, then use the large one.

6. Power supply must maintain regulation within operating V_{DD} range during instantaneous and operating maximum current conditions. If the positive injection current ($V_{IN} > V_{DD}$) is higher than I_{DD} , the injection current may flow out of V_{DD} and could result in external power supply going out of regulation. Ensure that external V_{DD} load will shunt current higher than maximum injection current when the MCU is not consuming power, such as no system clock is present, or clock rate is very low (which would reduce overall power consumption).

Table 3. LVD and POR Specification

| Symbol | C | Description | | Min | Typ | Max | Unit |
|---------------------|---|---|-----------------------------|------|------|------|------|
| V _{POR} | D | POR re-arm voltage ^{1, 2} | | 1.5 | 1.75 | 2.0 | V |
| V _{LVDH} | C | Falling low-voltage detect threshold - high range (LVDV = 1) ³ | | 4.2 | 4.3 | 4.4 | V |
| V _{LVW1H} | C | Falling low-voltage warning threshold - high range | Level 1 falling (LVWV = 00) | 4.3 | 4.4 | 4.5 | V |
| V _{LVW2H} | C | | Level 2 falling (LVWV = 01) | 4.5 | 4.5 | 4.6 | V |
| V _{LVW3H} | C | | Level 3 falling (LVWV = 10) | 4.6 | 4.6 | 4.7 | V |
| V _{LVW4H} | C | | Level 4 falling (LVWV = 11) | 4.7 | 4.7 | 4.8 | V |
| V _{HYSH} | C | High range low-voltage detect/warning hysteresis | | — | 100 | — | mV |
| V _{LVDL} | C | Falling low-voltage detect threshold - low range (LVDV = 0) | | 2.56 | 2.61 | 2.66 | V |
| V _{LVDW1L} | C | Falling low-voltage warning threshold - low range | Level 1 falling (LVWV = 00) | 2.62 | 2.7 | 2.78 | V |
| V _{LVDW2L} | C | | Level 2 falling (LVWV = 01) | 2.72 | 2.8 | 2.88 | V |
| V _{LVDW3L} | C | | Level 3 falling (LVWV = 10) | 2.82 | 2.9 | 2.98 | V |
| V _{LVDW4L} | C | | Level 4 falling (LVWV = 11) | 2.92 | 3.0 | 3.08 | V |
| V _{HYSDL} | C | Low range low-voltage detect hysteresis | | — | 40 | — | mV |
| V _{HYSWL} | C | Low range low-voltage warning hysteresis | | — | 80 | — | mV |
| V _{BG} | P | Buffered bandgap output ⁴ | | 1.14 | 1.16 | 1.18 | V |

1. Maximum is highest voltage that POR is guaranteed.
2. POR ramp time must be longer than 20us/V to get a stable startup.
3. Rising thresholds are falling threshold + hysteresis.
4. Voltage factory trimmed at $V_{DD} = 5.0$ V, Temp = 25 °C

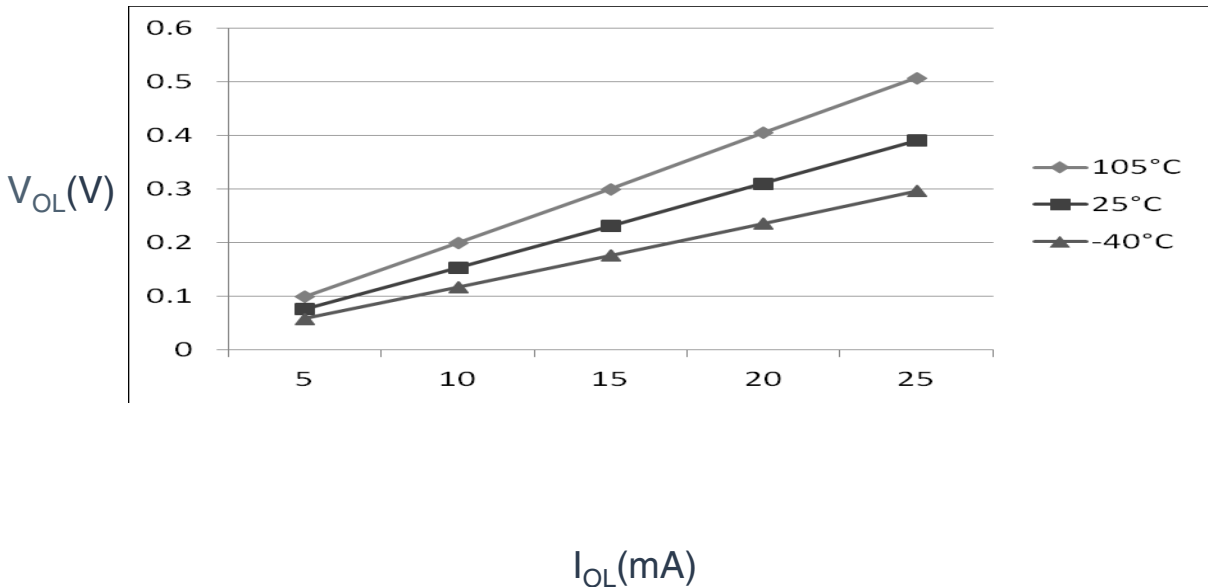


Figure 7. Typical I_{OL} Vs. V_{OL} (high drive strength) ($V_{DD} = 5\text{ V}$)

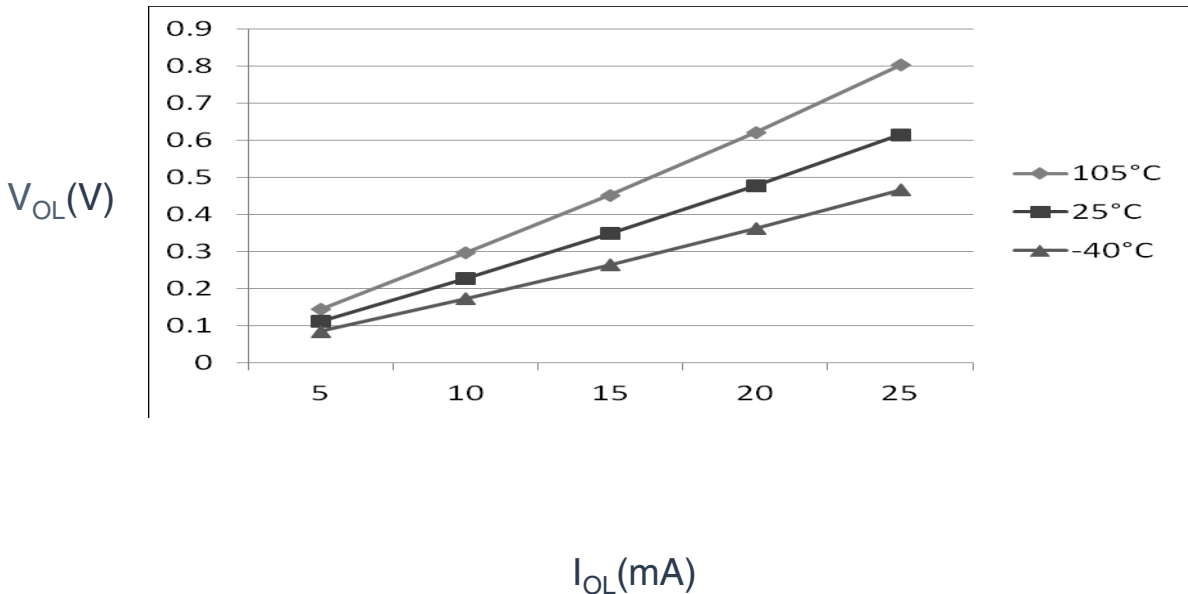


Figure 8. Typical I_{OL} Vs. V_{OL} (high drive strength) ($V_{DD} = 3\text{ V}$)

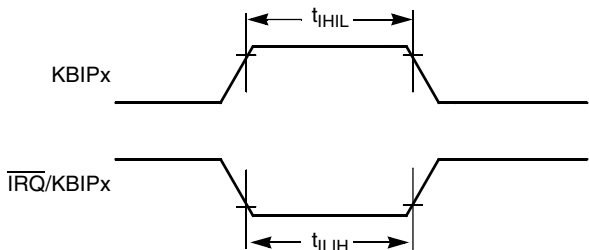


Figure 10. IRQ/KBIPx timing

5.2.2 Debug trace timing specifications

Table 7. Debug trace operating behaviors

| Symbol | Description | Min. | Max. | Unit |
|-----------|--------------------------|---------------------|------|------|
| t_{cyc} | Clock period | Frequency dependent | | MHz |
| t_{wl} | Low pulse width | 2 | — | ns |
| t_{wh} | High pulse width | 2 | — | ns |
| t_r | Clock and data rise time | — | 3 | ns |
| t_f | Clock and data fall time | — | 3 | ns |
| t_s | Data setup | 3 | — | ns |
| t_h | Data hold | 2 | — | ns |

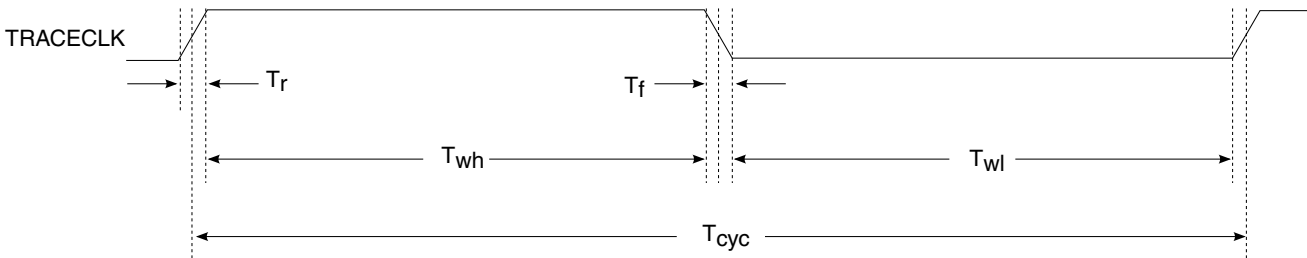


Figure 11. TRACE_CLKOUT specifications

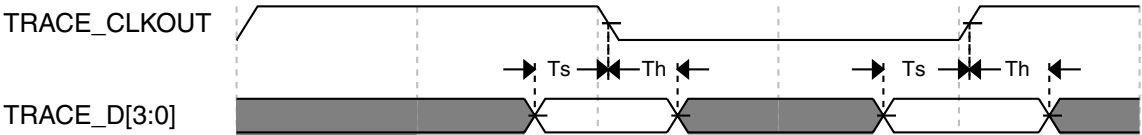


Figure 12. Trace data specifications

5.2.3 FTM module timing

Synchronizer circuits determine the shortest input pulses that can be recognized or the fastest clock that can be used as the optional external source to the timer counter. These synchronizers operate from the current bus rate clock.

Table 8. FTM input timing

| No. | C | Function | Symbol | Min | Max | Unit |
|-----|---|---------------------------|------------|-----|-------------|-----------|
| 1 | D | External clock frequency | f_{TCLK} | 0 | $f_{Bus}/4$ | Hz |
| 2 | D | External clock period | t_{TCLK} | 4 | — | t_{cyc} |
| 3 | D | External clock high time | t_{clkh} | 1.5 | — | t_{cyc} |
| 4 | D | External clock low time | t_{clkl} | 1.5 | — | t_{cyc} |
| 5 | D | Input capture pulse width | t_{ICPW} | 1.5 | — | t_{cyc} |

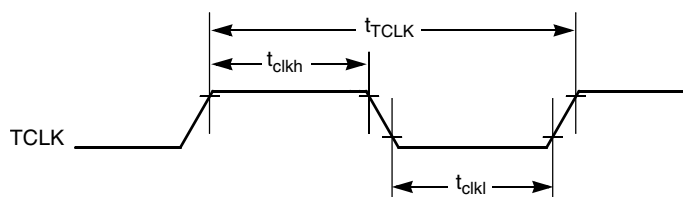


Figure 13. Timer external clock

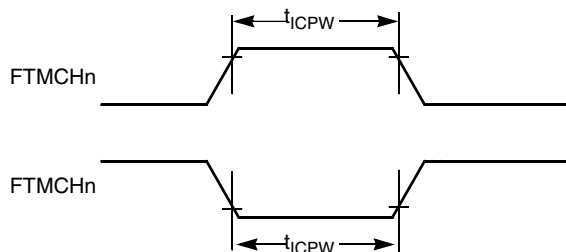


Figure 14. Timer input capture pulse

5.3 Thermal specifications

5.3.1 Thermal characteristics

This section provides information about operating temperature range, power dissipation, and package thermal resistance. Power dissipation on I/O pins is usually small compared to the power dissipation in on-chip logic and voltage regulator circuits, and it is user-determined rather than being controlled by the MCU design. To take $P_{I/O}$ into account in power calculations, determine the difference between actual pin voltage and V_{SS} or V_{DD} and multiply by the pin current for each I/O pin. Except in cases of unusually high pin current (heavy loads), the difference between pin voltage and V_{SS} or V_{DD} will be very small.

Table 9. Thermal characteristics

| Rating | Symbol | Value | Unit |
|--|--------------------|---------------------------|------|
| Operating temperature range (packaged) | T_A ¹ | T_L to T_H -40 to 105 | °C |
| Junction temperature range | T_J | -40 to 150 | °C |
| Thermal resistance single-layer board | | | |
| 44-pin LQFP | $R_{\theta JA}$ | 76 | °C/W |
| 32-pin LQFP | $R_{\theta JA}$ | 88 | °C/W |
| 20-pin SOIC | $R_{\theta JA}$ | 82 | °C/W |
| 20-pin TSSOP | $R_{\theta JA}$ | 116 | °C/W |
| 16-pin TSSOP | $R_{\theta JA}$ | 130 | °C/W |
| Thermal resistance four-layer board | | | |
| 44-pin LQFP | $R_{\theta JA}$ | 54 | °C/W |
| 32-pin LQFP | $R_{\theta JA}$ | 59 | °C/W |
| 20-pin SOIC | $R_{\theta JA}$ | 54 | °C/W |
| 20-pin TSSOP | $R_{\theta JA}$ | 76 | °C/W |
| 16-pin TSSOP | $R_{\theta JA}$ | 87 | °C/W |

- Maximum T_A can be exceeded only if the user ensures that T_J does not exceed the maximum. The simplest method to determine T_J is: $T_J = T_A + R_{\theta JA} \times \text{chip power dissipation}$.

6 Peripheral operating requirements and behaviors

6.1 External oscillator (XOSC) and ICS characteristics

Table 10. XOSC and ICS specifications (temperature range = -40 to 105 °C ambient)

| Num | C | Characteristic | | Symbol | Min | Typical ¹ | Max | Unit |
|-----|---|---|---|---------------------|-----------------------|----------------------|---------|-------------|
| 1 | C | Oscillator crystal or resonator | Low range (RANGE = 0) | f_{lo} | 31.25 | 32.768 | 39.0625 | kHz |
| | C | | High range (RANGE = 1) FEE or FBE mode ² | f_{hi} | 4 | — | 20 | MHz |
| | C | | High range (RANGE = 1), high gain (HGO = 1), FBELP mode | f_{hi} | 4 | — | 20 | MHz |
| | C | | High range (RANGE = 1), low power (HGO = 0), FBELP mode | f_{hi} | 4 | — | 20 | MHz |
| 2 | D | Load capacitors | | C1, C2 | See Note ³ | | | |
| 3 | D | Feedback resistor | Low Frequency, Low-Power Mode ⁴ | R_F | — | — | — | MΩ |
| | | | Low Frequency, High-Gain Mode | | — | 10 | — | MΩ |
| | | | High Frequency, Low-Power Mode | | — | 1 | — | MΩ |
| | | | High Frequency, High-Gain Mode | | — | 1 | — | MΩ |
| 4 | D | Series resistor - Low Frequency | Low-Power Mode ⁴ | R_S | — | — | — | kΩ |
| | | | High-Gain Mode | | — | 200 | — | kΩ |
| 5 | D | Series resistor - High Frequency | Low-Power Mode ⁴ | R_S | — | — | — | kΩ |
| | D | Series resistor - High Frequency, High-Gain Mode | 4 MHz | | — | 0 | — | kΩ |
| | D | | 8 MHz | | — | 0 | — | kΩ |
| | D | | 16 MHz | | — | 0 | — | kΩ |
| 6 | C | Crystal start-up time Low range = 32.768 kHz crystal; High range = 20 MHz crystal ^{5, 6} | Low range, low power | t_{CSTL} | — | 1000 | — | ms |
| | C | | Low range, high power | | — | 800 | — | ms |
| | C | | High range, low power | t_{CSTH} | — | 3 | — | ms |
| | C | | High range, high power | | — | 1.5 | — | ms |
| 7 | T | Internal reference start-up time | | t_{IRST} | — | 20 | 50 | μs |
| 8 | D | Square wave input clock frequency | FEE or FBE mode ² | f_{extal} | 0.03125 | — | 5 | MHz |
| | D | | FBELP mode | | 0 | — | 20 | MHz |
| 9 | P | Average internal reference frequency - trimmed | | f_{int_t} | — | 31.25 | — | kHz |
| 10 | P | DCO output frequency range - trimmed | | f_{dco_t} | 16 | — | 20 | MHz |
| 11 | P | Total deviation of DCO output from trimmed frequency ⁵ | Over full voltage and temperature range | Δf_{dco_t} | — | — | ±2.0 | % f_{dco} |
| | C | | Over fixed voltage and temperature range of 0 to 70 °C | | | | ±1.0 | |
| 12 | C | FLL acquisition time ^{5, 7} | | $t_{Acquire}$ | — | — | 2 | ms |

Table continues on the next page...

6.3 Analog

6.3.1 ADC characteristics

Table 12. 5 V 12-bit ADC operating conditions

| Characteristic | Conditions | Symb | Min | Typ ¹ | Max | Unit | Comment |
|--------------------------------|---|------------------|------------|------------------|------------|------------|-----------------|
| Supply voltage | Absolute | V_{DDA} | 2.7 | — | 5.5 | V | — |
| | Delta to V_{DD} ($V_{DD}-V_{DDAD}$) | ΔV_{DDA} | -100 | 0 | +100 | mV | |
| Ground voltage | Delta to V_{SS} ($V_{SS}-V_{SSA}$) ² | ΔV_{SSA} | -100 | 0 | +100 | mV | |
| Input voltage | | V_{ADIN} | V_{REFL} | — | V_{REFH} | V | |
| Input capacitance | | C_{ADIN} | — | 4.5 | 5.5 | pF | |
| Input resistance | | R_{ADIN} | — | 3 | 5 | k Ω | — |
| Analog source resistance | 12-bit mode | R_{AS} | — | — | 2 | k Ω | External to MCU |
| | • $f_{ADCK} > 4$ MHz | | — | — | 5 | | |
| | • $f_{ADCK} < 4$ MHz | | — | — | 5 | | |
| | 10-bit mode | | — | — | 5 | | |
| | • $f_{ADCK} > 4$ MHz | | — | — | 10 | | |
| | • $f_{ADCK} < 4$ MHz | | — | — | 10 | | |
| ADC conversion clock frequency | 8-bit mode (all valid f_{ADCK}) | | — | — | 10 | | |
| | High speed (ADLPC=0) | f_{ADCK} | 0.4 | — | 8.0 | MHz | — |
| | Low power (ADLPC=1) | | 0.4 | — | 4.0 | | |

1. Typical values assume $V_{DDA} = 5.0$ V, Temp = 25°C, $f_{ADCK}=1.0$ MHz unless otherwise stated. Typical values are for reference only and are not tested in production.
2. DC potential difference.

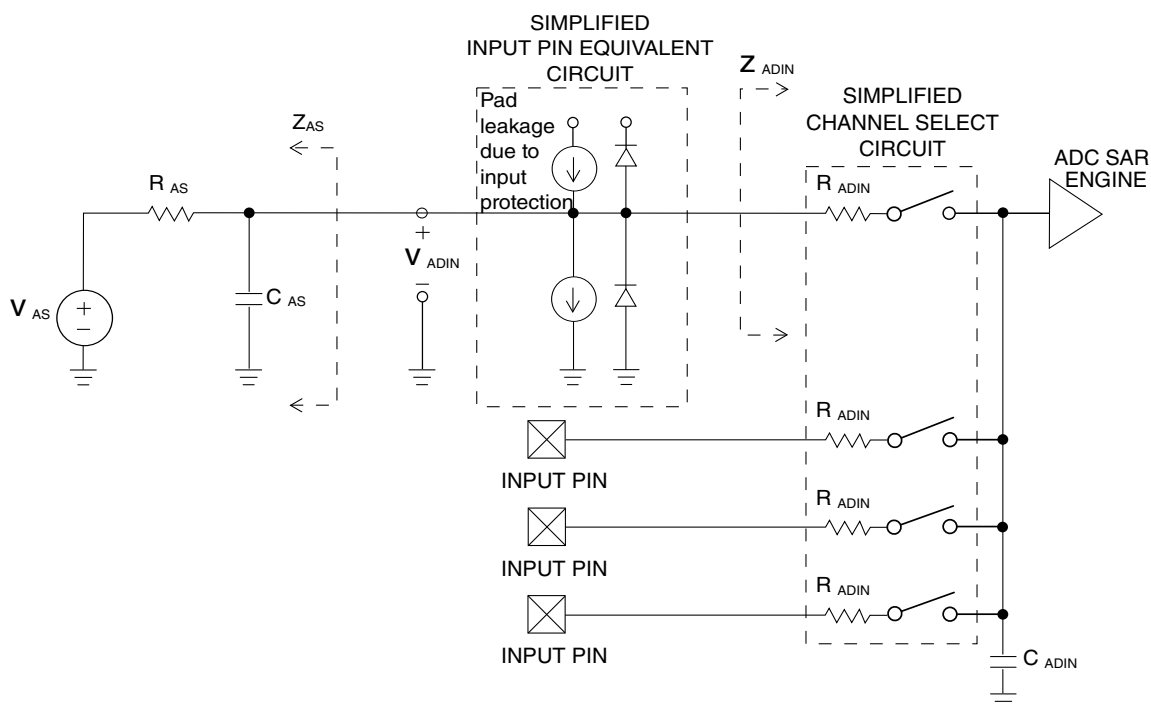


Figure 16. ADC input impedance equivalency diagram

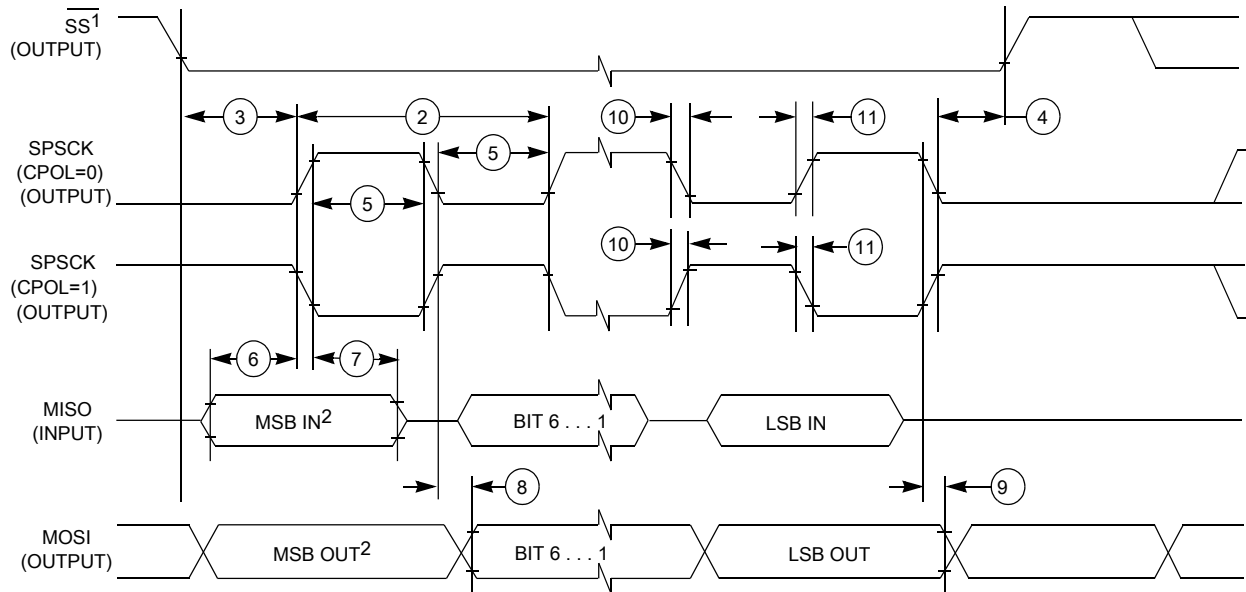
Table 13. 12-bit ADC Characteristics ($V_{REFH} = V_{DDA}$, $V_{REFL} = V_{SSA}$)

| Characteristic | Conditions | C | Symb | Min | Typ ¹ | Max | Unit |
|---|-------------------------|---|--------------------|-----|------------------|-----|------|
| Supply current ADLPC = 1 ADLSMP = 1 ADCO = 1 | | T | I _{DDA} | — | 133 | — | μA |
| Supply current ADLPC = 1 ADLSMP = 0 ADCO = 1 | | T | I _{DDA} | — | 218 | — | μA |
| Supply current ADLPC = 0 ADLSMP = 1 ADCO = 1 | | T | I _{DDA} | — | 327 | — | μA |
| Supply current ADLPC = 0 ADLSMP = 0 ADCO = 1 | | T | I _{DDAD} | — | 582 | 990 | μA |
| Supply current | Stop, reset, module off | T | I _{DDA} | — | 0.011 | 1 | μA |
| ADC asynchronous clock source | High speed (ADLPC = 0) | P | f _{ADACK} | 2 | 3.3 | 5 | MHz |

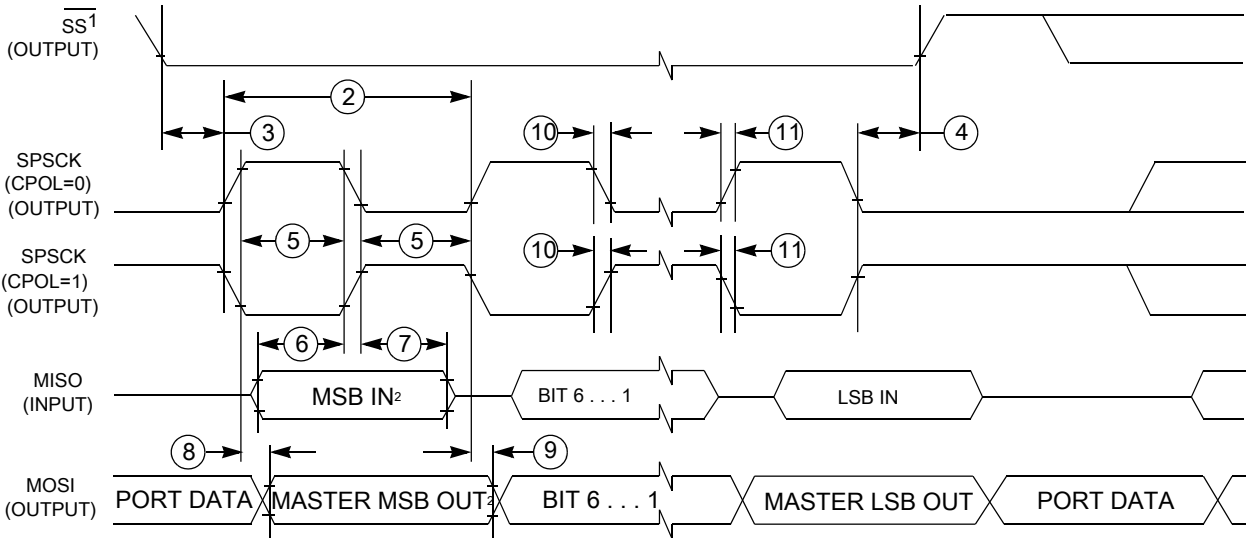
Table continues on the next page...

Table 15. SPI master mode timing (continued)

| Nu m. | Symbol | Description | Min. | Max. | Unit | Comment |
|-------|----------|------------------|------|------|------|---------|
| | t_{FI} | Fall time input | | | | |
| 11 | t_{RO} | Rise time output | — | 25 | ns | — |
| | t_{FO} | Fall time output | | | | |



1. If configured as an output.
2. LSBF = 0. For LSBF = 1, bit order is LSB, bit 1, ..., bit 6, MSB.

Figure 17. SPI master mode timing (CPHA=0)


1. If configured as output
2. LSBF = 0. For LSBF = 1, bit order is LSB, bit 1, ..., bit 6, MSB.

Figure 18. SPI master mode timing (CPHA=1)

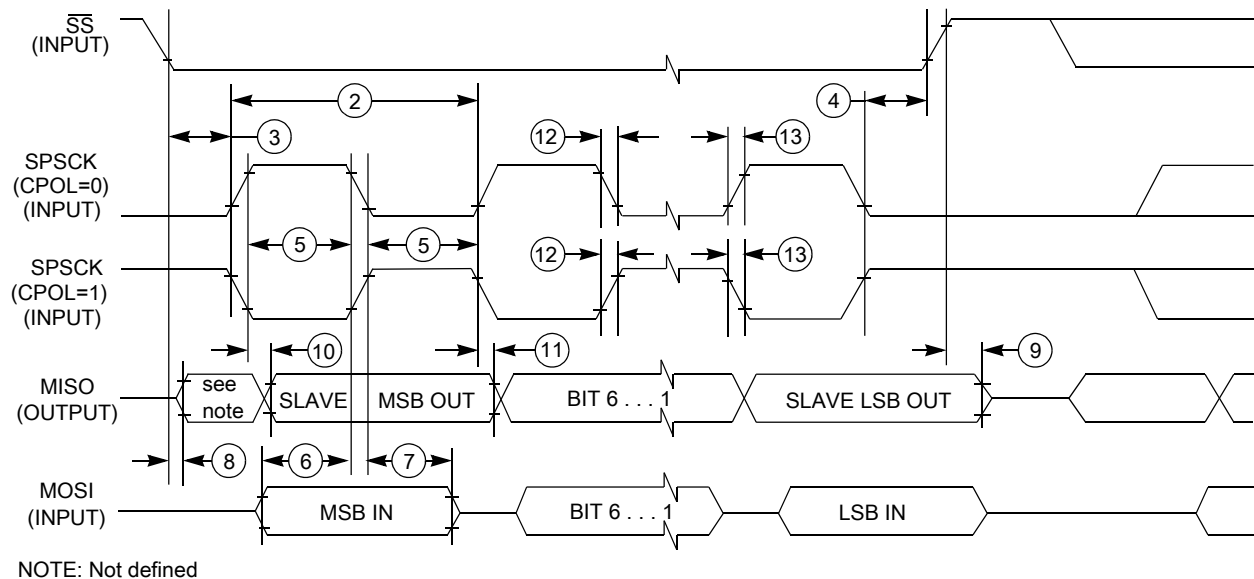


Figure 20. SPI slave mode timing (CPHA=1)

7 Dimensions

7.1 Obtaining package dimensions

Package dimensions are provided in package drawings.

To find a package drawing, go to freescale.com and perform a keyword search for the drawing's document number:

| If you want the drawing for this package | Then use this document number |
|--|-------------------------------|
| 16-pin TSSOP | 98ASH70247A |
| 20-pin SOIC | 98ASB42343B |
| 20-pin TSSOP | 98ASH70169A |
| 32-pin LQFP | 98ASH70029A |
| 44-pin LQFP | 98ASS23225W |

Table 17. Pin availability by package pin-count (continued)

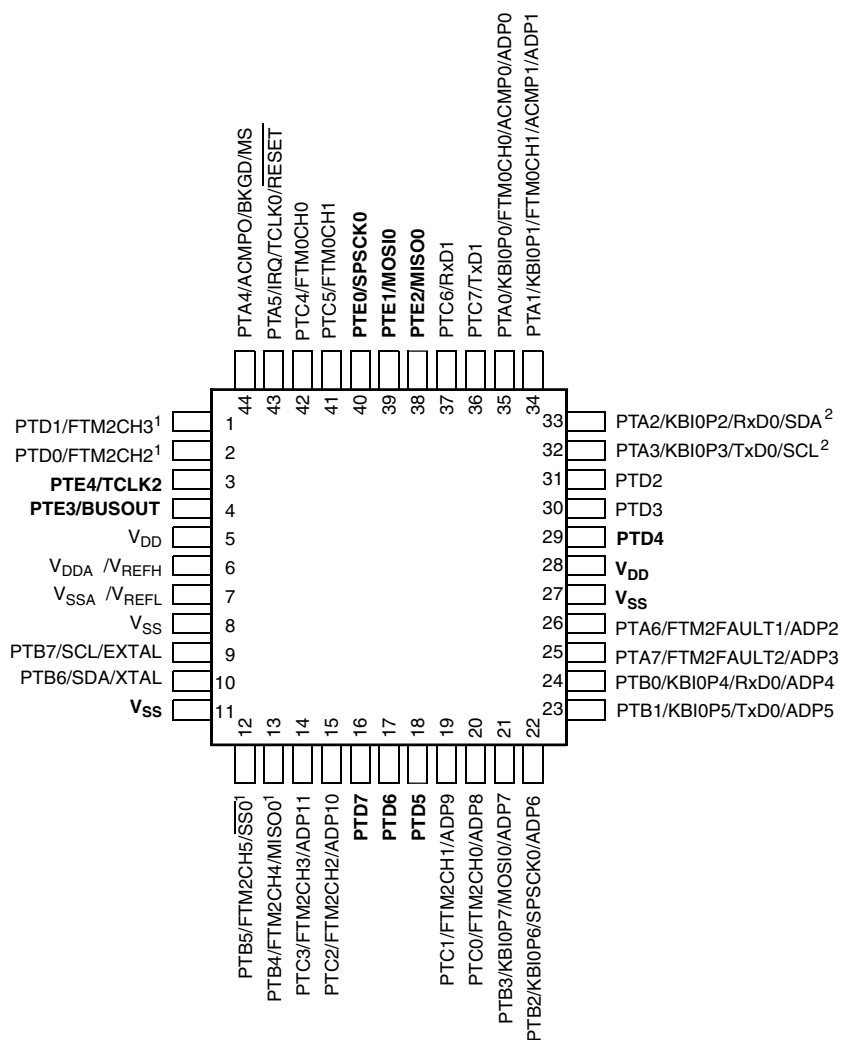
| Pin Number | | | | Lowest Priority <-- --> Highest | | | | |
|------------|---------|----------|----------|---------------------------------|--------|---------|-------|-------|
| 44-LQFP | 32-LQFP | 20-TSSOP | 16-TSSOP | Port Pin | Alt 1 | Alt 2 | Alt 3 | Alt 4 |
| 29 | — | — | — | PTD4 | — | — | — | — |
| 30 | 21 | — | — | PTD3 | — | — | — | — |
| 31 | 22 | — | — | PTD2 | — | — | — | — |
| 32 | 23 | 17 | 13 | PTA3 ² | KBI0P3 | TXD0 | SCL | — |
| 33 | 24 | 18 | 14 | PTA2 ² | KBI0P2 | RXD0 | SDA | — |
| 34 | 25 | 19 | 15 | PTA1 | KBI0P1 | FTM0CH1 | ACMP1 | ADP1 |
| 35 | 26 | 20 | 16 | PTA0 | KBI0P0 | FTM0CH0 | ACMP0 | ADP0 |
| 36 | 27 | — | — | PTC7 | — | TxD1 | — | — |
| 37 | 28 | — | — | PTC6 | — | RxD1 | — | — |
| 38 | — | — | — | PTE2 | — | MISO0 | — | — |
| 39 | — | — | — | PTE1 | — | MOSI0 | — | — |
| 40 | — | — | — | PTE0 | — | SPSCK0 | — | — |
| 41 | 29 | — | — | PTC5 | — | FTM0CH1 | — | — |
| 42 | 30 | — | — | PTC4 | — | FTM0CH0 | — | — |
| 43 | 31 | 1 | 1 | PTA5 | IRQ | TCLK0 | — | RESET |
| 44 | 32 | 2 | 2 | PTA4 | — | ACMPO | BKGD | MS |

1. This is a high current drive pin when operated as output.
2. This is a true open-drain pin when operated as output.

Note

When an alternative function is first enabled, it is possible to get a spurious edge to the module. User software must clear any associated flags before interrupts are enabled. The table above illustrates the priority if multiple modules are enabled. The highest priority module will have control over the pin. Selecting a higher priority pin function with a lower priority function already enabled can cause spurious edges to the lower priority module. Disable all modules that share a pin before enabling another module.

8.2 Device pin assignment

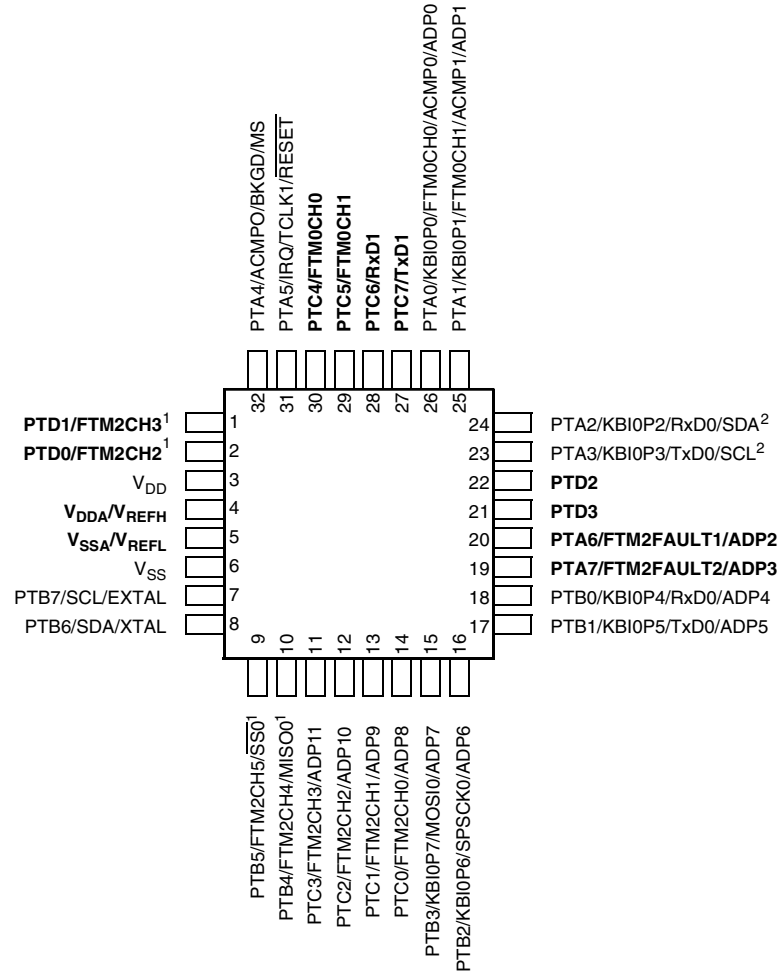


Pins in **bold** are not available on less pin-count packages.

1. High source/sink current pins

1. High source/sink can
2. True open drain pins

Figure 21. MC9S08PA16 44-pin LQFP package

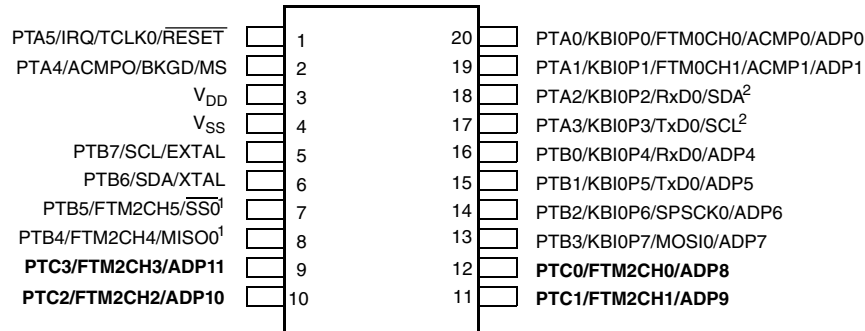


Pins in **bold** are not available on less pin-count packages.

1. High source/sink current pins

2. True open drain pins

Figure 22. MC9S08PA16 32-pin LQFP package

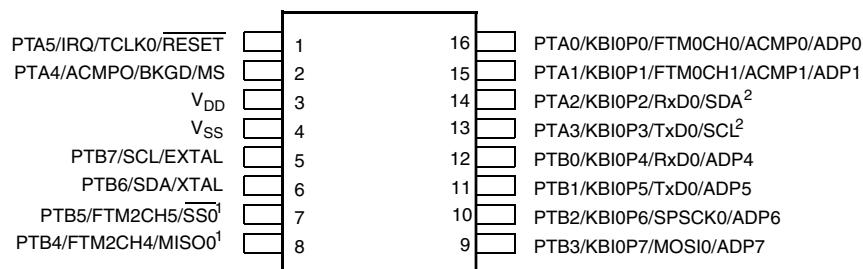


Pins in **bold** are not available on less pin-count packages.

1. High source/sink current pins

2. True open drain pins

Figure 23. MC9S08PA16 20-pin SOIC and TSSOP package



Pins in **bold** are not available on less pin-count packages.

1. High source/sink current pins

2. True open drain pins

Figure 24. MC9S08PA16 16-pin TSSOP package

9 Revision history

The following table provides a revision history for this document.

Table 18. Revision history

| Rev. No. | Date | Substantial Changes |
|----------|---------|---|
| 1 | 10/2012 | Initial public release |
| 2 | 09/2014 | <ul style="list-style-type: none"> Updated V_{OH} and V_{OL} in DC characteristics Updated footnote on the $S3I_{DD}$ in Supply current characteristics Added EMC radiated emissions operating behaviors Updated the typical of f_{int_t} to 31.25 kHz and updated footnote to $t_{Acquire}$ in External oscillator (XOSC) and ICS characteristics Updated the assumption for all the timing values in SPI switching specifications Updated the rating descriptions for t_{Rise} and t_{Fall} in Control timing Updated the part number format to add new field for new part numbers in Fields |
| 3 | 06/2015 | <ul style="list-style-type: none"> Corrected the Min. of the t_{extrst} in Control timing Updated Thermal characteristics to add footnote to the T_A and removed redundant information. Updated the symbol of θ_{JA} to $R_{\theta JA}$. |

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